

Search Notes**Application/Control No.**

10/742,919

Examiner

Tai Duong

Applicant(s)/Patent under Reexamination

LEE ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	110	9/17/2007	TD
	111		
	141		
	153		
	156		
	190		
430	5		
	6		
	7		
	20		
	321		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PGPUB; USPAT; EPO; JPO; DERWENT; IBM TDB) see search history printout	9/17/2007	TD

INTERFERENCE SEARCHED

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